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In the Claims

Claims 1-60 (canceled).

Claim 61 (currently amended): A semiconductor construction, comprising:

a semiconductor substrate;

an insulative material over the semiconductor substrate;

trenches extending within the insulative material;

a first conductive wiring layer within the trenches and partially filling the trenches, the first conductive wiring layer comprising n-type conductively-doped silicon;

porous silicon over <u>and directly against the n-type conductively-doped silicon of</u> the first conductive wiring layer within the trenches, the porous silicon being p-type doped;

an active molecular switchable memory material within pores of the <u>p-type doped</u> porous silicon, the active molecular switchable memory material being selected from a group consisting of redox-active catenane, redox-active rotaxane, redox-active pseudorotaxane, and mixtures thereof; and

a second conductive wiring layer over <u>and directly against</u> the <u>p-type doped</u> porous silicon and active molecular switchable memory material therein.

Claim 62 (original): The switchable circuit device of claim 61 wherein the active molecular switchable memory material comprises two stable states which are interchanged by oxidation and reduction of the material.

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Claim 63 (currently amended): The semiconductor construction of claim 61 wherein the active molecular switchable memory material comprises a redox-active catenane.

Claim 64 (currently amended): The semiconductor construction of claim 61 wherein the active molecular switchable memory material comprises a redox-active rotaxane.

Claim 65 (currently amended): The semiconductor construction of claim 61 wherein the active molecular switchable memory material comprises a redox-active pseudorotaxane.

Claims 66 and 67 (cancelled).

Claim 68 (currently amended): The semiconductor construction of claim 61 wherein the first and second conductive wiring layers comprises layer comprises conductively doped silicon.

Claim 69 (original): The semiconductor construction of claim 61 wherein the first conductive wiring layer defines lines extending primarily along a first direction; and wherein the second conductive wiring layer is formed in a shape of a line extending primarily along a second direction substantially perpendicular to the first direction.